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Observation & characterisation of the charge screening effect in LGAD

V. Sola for the Team



The Team

M. Abujami, R. Arcidiacono, N. Cartiglia, M. Costa, M. Ferrero, G. Gioachin, S. Giordanengo, L. Lanteri, F. Mas Milian, L. Menzio, V. Monaco, D.M. Montalván Olivares, R. Mulargia, R. Sacchi, F. Siviero, A. Staiano, M. Tornago Università degli Studi di Torino, Università del Piemonte Orientale, INFN

P. Asenov, T. Croci, A. Fondacci, A. Morozzi, F. Moscatelli, D. Passeri Università degli Studi di Perugia, CNR-IOM, INFN

M. Boscardin, M. Centis Vignali, G.-F. Dalla Betta, L. Pancheri, G. Paternoster Fondazione Bruno Kessler, Università di Trento, TIFPA



A lot of interest in the study of the charge screening effects raised within the RD50 Community Representative examples

- ▷ E. Curras Rivera el al., Gain suppression mechanism observed in Low Gain Avalanche Detectors, TREDI 2021 Virtual
- ▷ G. Kramberger et al., Effects of charge screening in LGADs, 39th RD50 Workshop (2021) Valencia

We want to further investigate the gain suppression mechanism via

- \rightarrow TCT measurements
- \rightarrow Low energy protons
- \rightarrow TCAD simulation

An LGAD-PiN sensor from the FBK UFSD2 production has been used for tests [doi:10.1016/j.nima.2018.07.060]



G(V) from TCT – Laser Intensity

Q_{PiN}

Gain =

at $V_{\text{bias}} \leq 100 \text{ V to}$

concentrate on the relative evolution of

the gain

TCT Setup from Particulars

Pico-second IR laser at 1064 nm Laser spot diameter $\sim 10 \, \mu m$ Cividec Broadband Amplifier (40dB) Oscilloscope LeCroy 640Zi Room temperature





 \rightarrow Gain suppression mechanism observed above 200 V

Gain & MIP – Torino Board + BB 40dB

G(V) from TCT – High Laser Intensity

TCT Setup from Particulars

Pico-second IR laser at 1064 nm Laser spot diameter ~ 10 μm Without external amplification Oscilloscope LeCroy 640Zi Room temperature



80 70 60 50 Gain 40 - - 40MIP - 🔺 - 60MIP 30 - • - 80MIP 20 10 0 0 50 100 150 200 250 300 350 Reverse Bias [V]

 \rightarrow Suppression of gain enhanced for laser intensity \geq 40 MIPs

Gain & MIP – Torino Board (+ BB 40dB)

G(V) from TCT – ZOOM

TCT Setup from Particulars

Pico-second IR laser at 1064 nm Laser spot diameter ~ 10 μm Without external amplification Oscilloscope LeCroy 640Zi Room temperature





 \rightarrow More than 50% of gain suppressed going from 1 to 80 MIPs

Gain & MIP – Torino Board (+ BB 40dB)

G(V) from β Particles – Comparison with TCT

β Particles Setup

Sensor on UCSC Board Cividec Broadband Amplifier (20dB) System transimpedance ~ 4700 Ω Oscilloscope LeCroy 640Zi Room temperature Trigger below the DUT



80 70 60 → 5MIP 50 Gain 40 - - 40MIP 30 -60MIP - • - 80MIP 20 10 0 50 100 150 200 250 300 350 0 Reverse Bias [V]

 \rightarrow Gain evolution from β particles between 1 and 3 MIPs

Gain & MIP – Laser + Beta

G(V) from Low-Energy Protons



Goal: use a medical facility for particle therapy to investigate the gain suppression mechanism with low energetic proton beams

Proton Energy [MeV]	Equivalent MIPs
62	5.0
110	3.3
170	2.4
226	2.0



Q(V) from Low-Energy Protons



CNAO Beam Test Setup

Same FBK UFSD2 LGAD-PiN under test Cividec Broadband Amplifier (40dB) Oscilloscope LeCroy 640Zi Room temperature Trigger behind the DUT





 \rightarrow Collected charge scales with the impinging proton energy

Q(E) from Low-Energy Protons



CNAO Beam Test Setup

Same FBK UFSD2 LGAD-PiN under test Cividec Broadband Amplifier (40dB) Oscilloscope LeCroy 640Zi Room temperature Trigger behind the DUT



Collected charge with proton energy 60 Preliminary -- 150 V Collected Charge [a.u.] 50 --- 200 V 40 --- 250 V --- 275 V 30 20 10 0 50 100 150 200 250 Energy [MeV]

 \rightarrow At fixed V_{bias}, the collected charge scales with the energy

Q(E) from Low-Energy Protons



The collected charge distributions have been normalised to the one at $V_{bias} = 150 V$, to observe the relative evolution of the collected charge with the proton energy



Normalised collected charge with proton energy 2,2 35 % more charge - 150 V Normalised Collected Charge Preliminary w.r.t. $E_{p} = 62 \text{ MeV}$ 2,0 -- 200 V --- 250 V 1,8 🗕 275 V 1,6 1,4 1,2 1,0 0,8 50 100 150 200 250 Energy [MeV]

 \rightarrow Higher energies show a steeper increase of the collected charge

G(V) from Low-Energy Protons



 $Gain = \frac{Q_{LGAD}}{Q_{PiN}}$

To make the gain measurement independent of the resolution on the Q_{PiN} , all the curves have been normalised at low $V_{bias} \le 150 V$





 \rightarrow A gain reduction is observed with decreasing proton energy



G(V) from Low-Energy Protons + β



 $Gain = \frac{Q_{LGAD}}{Q_{PiN}}$

To make the gain measurement independent of the resolution on the Q_{PiN} , all the curves have been normalised at low $V_{bias} \le 150 \text{ V}$



Protons with different energy + beta – Gain 30 Preliminary 25 62 MeV 20 --- 110 MeV Gain 15 --- 170 MeV 10 --- 226 MeV -+- beta 5 0 0 50 100 150 200 250 300 Reverse Bias [V]

 \rightarrow Gain reduction is more pronounced if compared to β particles

TCAD Simulation of the Impact Ionisation



A TCAD device-level simulation has been performed in 2D and 3D domain

 \rightarrow Qualitative study of saturation of the gain mechanism



The *Heavylon* function is activated in Sentaurus to emulate an ion travelling through the detector to study charge multiplication with the passage of a charged particle

The *Heavylon* function allows the user to control the amount of ionisation energy released by the impinging ion

TCAD Simulation of the Impact Ionisation



A TCAD device-level simulation has been performed in 2D and 3D domain

 \rightarrow Qualitative study of saturation of the gain mechanism





TCAD Simulation – 2D vs 3D Domain

 \rightarrow Impact of the high electic field region – e.g. 1 MIP



TCAD Simulation – 3D Domain



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 \rightarrow Impact of the high electic field region – e.g. 0.01 MIP



TCAD Simulation – 3D Domain







TCAD Simulation – 3D Domain



 \rightarrow Impact of the high electic field region – e.g. 24 MIP





- Gain suppression mechanism observed in TCT measurement while increasing the intensity of the laser stimulus
 - \rightarrow Results in agreement with previous observations from other groups
- Gain suppression mechanism observed for low-energy protons used in particle therapy
 - \rightarrow Preliminary results need further scrutiny
- To simulate the gain suppression mechanism at the device level, the 3D domain is necessary
 - → The gain suppression observed using the *Heavylon* function tends to overestimate the suppression observed in TCT data
 - \rightarrow The suppression behaviour is similar to the one observed for the low-energy protons



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- ⊳ RD50, CERN

Bonus Slides

TCT Setup – Signal Shapes from the Scope



TCT Setup – Signal Shapes @ 40 MIPs



CNAO Beam Test – Collected Charge



CNAO Beam Test – Collected Charge



Simulated Layout – Quasi 1D

✓ Quasi-1D structure



Simulated Layout – Fully 3D

✓ **Fully-3D** structure



✓ Silicon

- Width and Length 20 x 20 µm
 thickness 55 µm
 Epitaxial layer
 - Substrate 5 µm

50 µm

✓ Silicon Oxide

width 20 μm
thickness 1 μm

Transient Response – Heavylon model



TCAD Simulation – Stimulus Width

✓ Charge density generated by the MIP equivalent stimulus for different w_t



 \rightarrow w_t has very limited impact on the gain value, as it affects similarly the PiN and the LGAD

Time Evolution of the Ionisation Coefficients

